

Notice of References Cited

Application/Control No.

10/040,226

Applicant(s)/Patent Under
Reexamination
FEE ET AL.

Examiner

Christina Y. Leung

Art Unit

2633

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,101,010 A	08-2000	Konishi, Chitaka	398/14
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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